

Notice of References Cited	Application/Control No. 10/785,404		Applicant(s)/Patent Under Reexamination LEE, SANG-HAK	
	Examiner OLUWASEUN A. ADEGEYE		Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,580,462	06-2003	Inoue et al.	348/460
*	B	US-2003/0106064	06-2003	Plourde, Harold J. JR.	725/91
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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